

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/535,397 | Applicant(s)/Patent Under Reexamination AIBA, TOSHIYUKI | |
| | Examiner Francis T. Palo | Art Unit 3644 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------|----------------|
| * | A | US-4,972,627 | 11-1990 | Hori et al. | 47/64 |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|-----------------|-----------------|----------------|
| | N | CN 1268283 A | 10-2000 | China | HUANG et al. | A01G009/10 |
| | O | JP 2001231372 A | 08-2001 | Japan | SAGAWA, EITOKU | A01G009/10 |
| | P | JP 2002262671 A | 09-2002 | Japan | TSUBOI et al. | A01G009/02 |
| | Q | EP 1568269 A1 | 08-2005 | European Patent | AIBA, TOSHIYUKI | A01G009/10 |
| | R | JP 2005333850 A | 12-2005 | Japan | AEBA, TOSHIYUKI | A01G001/00 |
| | S | WO0182682A1 | 08-2001 | International | [ETEIN] | A01G009/10 |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.